



ALPHA & OMEGA
SEMICONDUCTOR

AO7415
20V P-Channel MOSFET

General Description

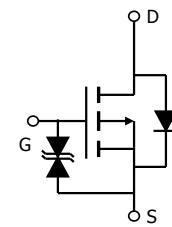
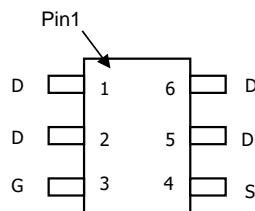
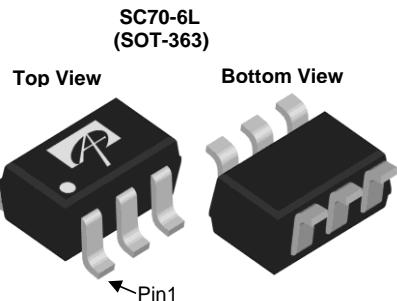
The AO7415 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch applications.

Product Summary

V_{DS}	-20V
I_D (at $V_{GS} = -10V$)	-2A
$R_{DS(ON)}$ (at $V_{GS} = -10V$)	< 100mΩ
$R_{DS(ON)}$ (at $V_{GS} = -4.5V$)	< 125mΩ
$R_{DS(ON)}$ (at $V_{GS} = -2.5V$)	< 170mΩ

Typical ESD protection

HBM Class 2



Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	-20	V
Gate-Source Voltage	V_{GS}	± 12	V
Continuous Drain Current ^A	I_D	-2	A
Current ^B		-1.6	
Pulsed Drain Current ^C	I_{DM}	-13	
Power Dissipation ^B	P_D	0.63	W
		0.4	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	R_{0JA}	160	200	°C/W
Maximum Junction-to-Ambient ^{A,D}		180	220	°C/W
Maximum Junction-to-Lead	R_{0JL}	130	160	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=-250\mu\text{A}$, $V_{\text{GS}}=0\text{V}$	-20			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}}=-20\text{V}$, $V_{\text{GS}}=0\text{V}$ $T_J=55^\circ\text{C}$			-1 -5	μA
I_{GSS}	Gate-Body leakage current	$V_{\text{DS}}=0\text{V}$, $V_{\text{GS}}= \pm 12\text{V}$			± 10	μA
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}$, $I_D=-250\mu\text{A}$	-0.5	-0.85	-1.2	V
$I_{\text{D}(\text{ON})}$	On state drain current	$V_{\text{GS}}=-4.5\text{V}$, $V_{\text{DS}}=-5\text{V}$	-13			A
$R_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance	$V_{\text{GS}}=-10\text{V}$, $I_D=-2\text{A}$ $T_J=125^\circ\text{C}$	80	100		$\text{m}\Omega$
		$V_{\text{GS}}=-4.5\text{V}$, $I_D=-1.3\text{A}$	98	125		$\text{m}\Omega$
		$V_{\text{GS}}=-2.5\text{V}$, $I_D=-1.0\text{A}$	130	170		$\text{m}\Omega$
g_{FS}	Forward Transconductance	$V_{\text{DS}}=-5\text{V}$, $I_D=-2\text{A}$		5		S
V_{SD}	Diode Forward Voltage	$I_S=-1\text{A}$, $V_{\text{GS}}=0\text{V}$		-0.76	-1	V
I_S	Maximum Body-Diode Continuous Current				-1	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{\text{GS}}=0\text{V}$, $V_{\text{DS}}=-10\text{V}$, $f=1\text{MHz}$	250	325	400	pF
C_{oss}	Output Capacitance		40	63	85	pF
C_{rss}	Reverse Transfer Capacitance		22	37	52	pF
R_g	Gate resistance	$V_{\text{GS}}=0\text{V}$, $V_{\text{DS}}=0\text{V}$, $f=1\text{MHz}$		11.2	17	Ω
SWITCHING PARAMETERS						
Q_g	Total Gate Charge	$V_{\text{GS}}=-4.5\text{V}$, $V_{\text{DS}}=-10\text{V}$, $I_D=-2\text{A}$		3.2	4.5	nC
Q_{gs}	Gate Source Charge			0.6		nC
Q_{gd}	Gate Drain Charge			0.9		nC
$t_{\text{D}(\text{on})}$	Turn-On DelayTime	$V_{\text{GS}}=-10\text{V}$, $V_{\text{DS}}=-10\text{V}$, $R_L=5\Omega$, $R_{\text{GEN}}=3\Omega$		11		ns
t_r	Turn-On Rise Time			5.5		ns
$t_{\text{D}(\text{off})}$	Turn-Off DelayTime			22		ns
t_f	Turn-Off Fall Time			8		ns
t_{rr}	Body Diode Reverse Recovery Time	$I_F=-2\text{A}$, $dI/dt=100\text{A}/\mu\text{s}$		6.1		ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=-2\text{A}$, $dI/dt=100\text{A}/\mu\text{s}$		1.4		nC

A. The value of R_{QJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ\text{C}$. The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=150^\circ\text{C}$, using $\leq 10\text{s}$ junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(\text{MAX})}=150^\circ\text{C}$. Ratings are based on low frequency and duty cycles to keep initial $T_J=25^\circ\text{C}$.

D. The R_{QJA} is the sum of the thermal impedance from junction to lead R_{QJL} and lead to ambient.

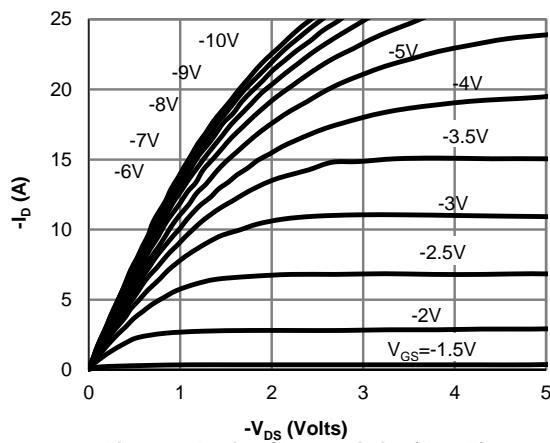
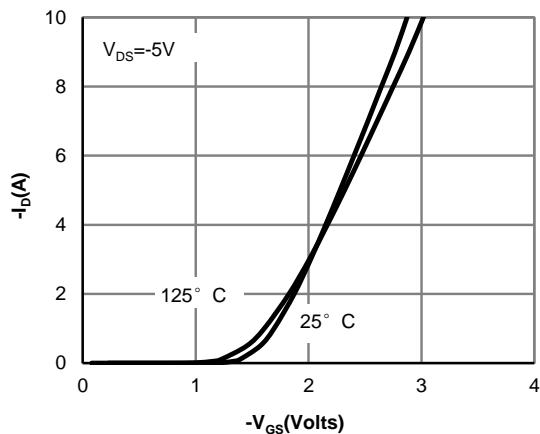
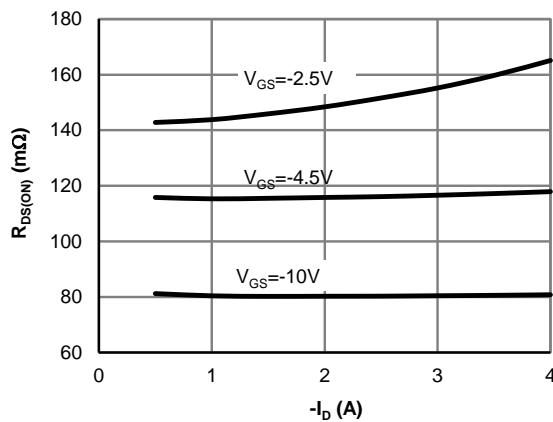
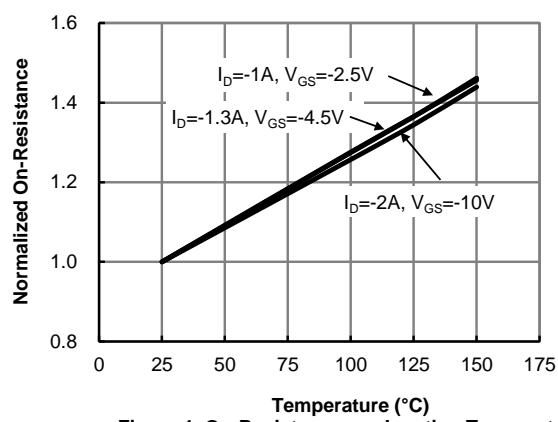
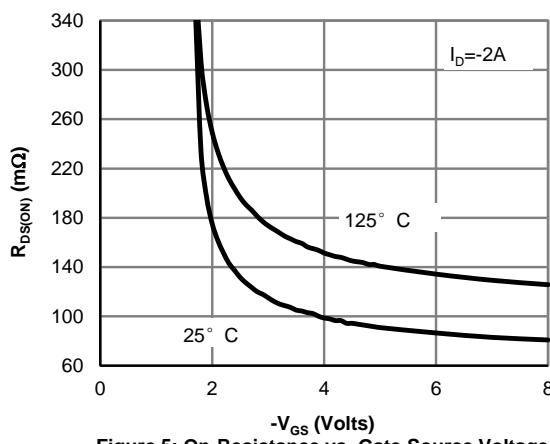
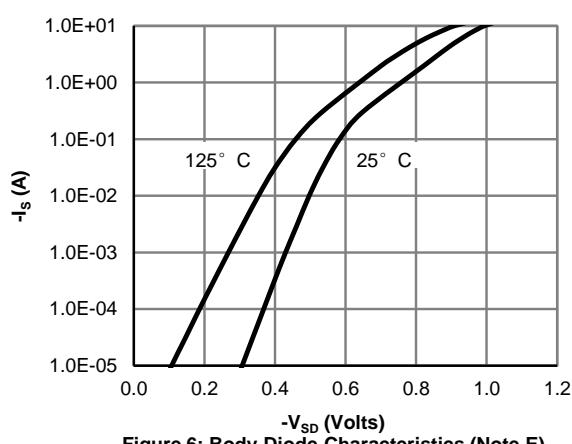
E. The static characteristics in Figures 1 to 6 are obtained using $<300\mu\text{s}$ pulses, duty cycle 0.5% max.

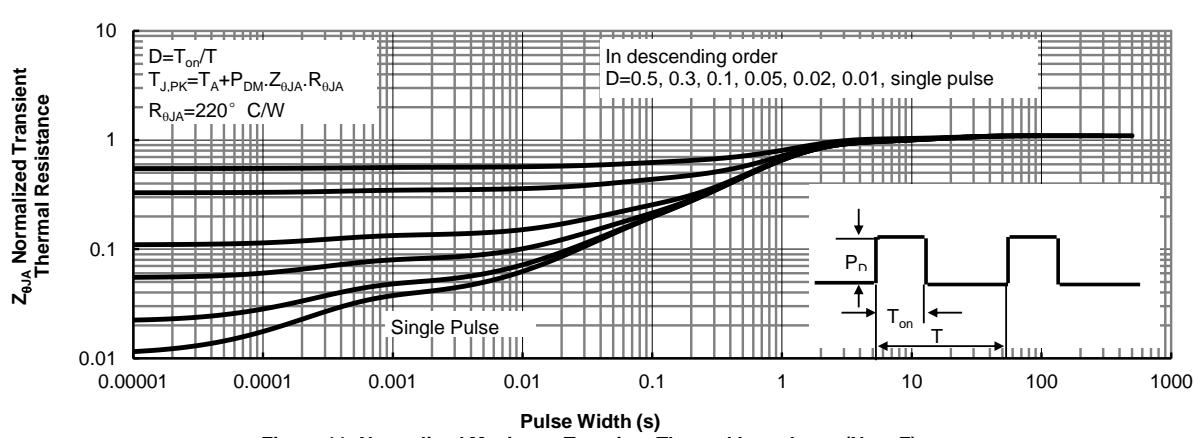
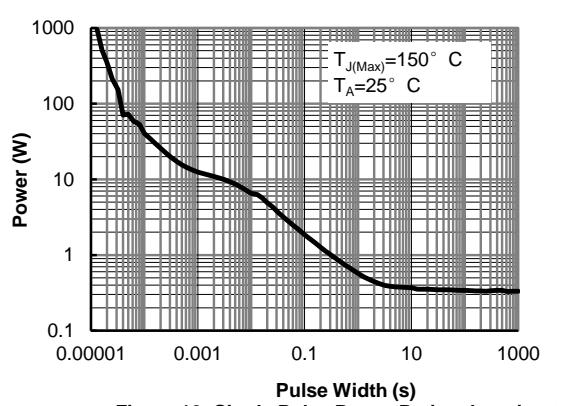
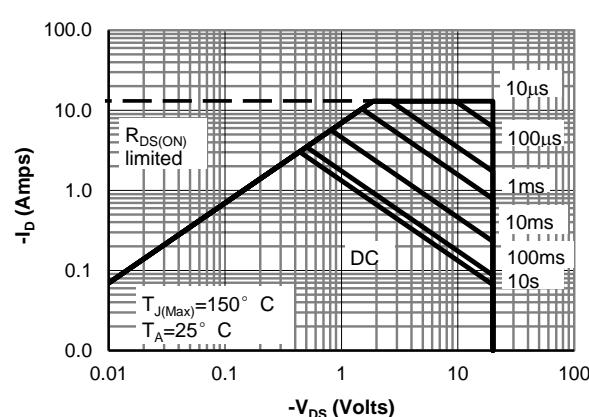
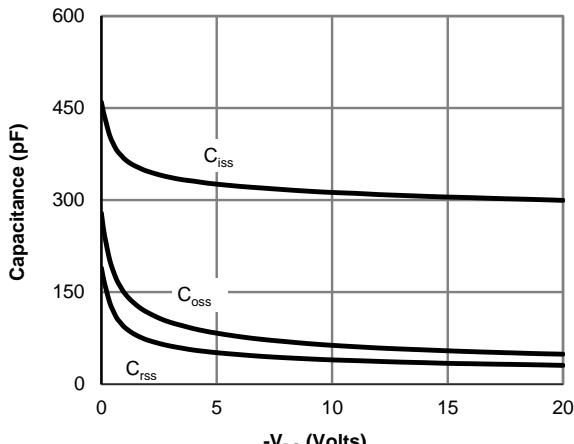
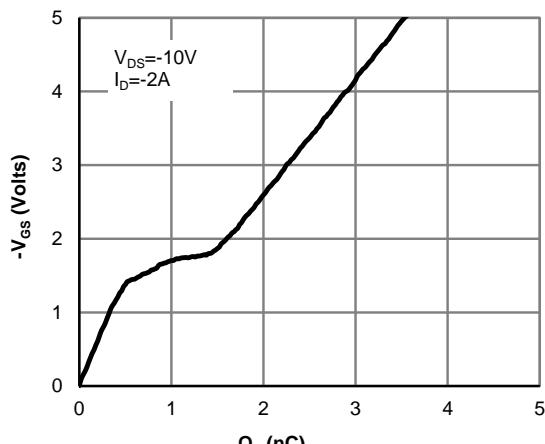
F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $T_{J(\text{MAX})}=150^\circ\text{C}$. The SOA curve provides a single pulse rating.

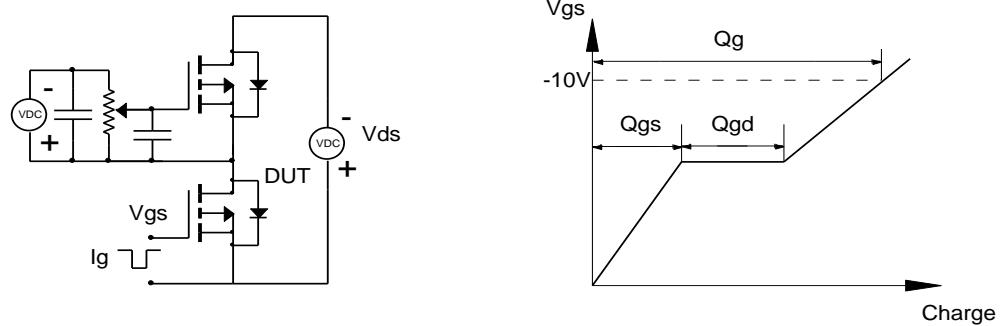
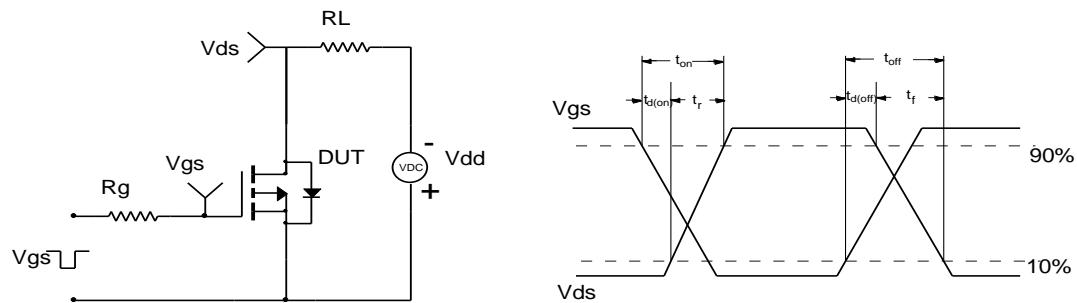
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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Fig 1: On-Region Characteristics (Note E)

Figure 2: Transfer Characteristics (Note E)

Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

Figure 4: On-Resistance vs. Junction Temperature (Note E)

Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS


Gate Charge Test Circuit & Waveform

Resistive Switching Test Circuit & Waveforms

Diode Recovery Test Circuit & Waveforms
